



AOD422, AOD422L (Green Product) N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOD422 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications. It is ESD protected. AOD422L (Green Product) is offered in a Lead Free package.

Features

 $V_{DS}(V) = 20V$

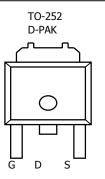
 $I_{D} = 10 A$

 $R_{DS(ON)} < 22m\Omega (V_{GS} = 4.5V)$

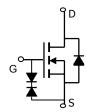
 $R_{DS(ON)}$ < 26m Ω (V_{GS} = 2.5V)

 $R_{DS(ON)} < 34m\Omega (V_{GS} = 1.8V)$

ESD Rating: 2000V HBM



Top View Drain Connected to Tab



Absolute Maximum Ratings T_A=25°C unless otherwise noted Parameter Symbol Units Maximum Drain-Source Voltage V_{DS} 20 V V_{GS} Gate-Source Voltage +8 Continuous Drain $T_C=25^{\circ}C$ 10 Current G $T_C=100^{\circ}C$ 10 Α Pulsed Drain Current I_{DM} 30 Avalanche Current C 15 Α I_{AR} Repetitive avalanche energy L=0.1mH ^C 26 mJ E_{AR} T_C=25°C 50 P_{D} W Power Dissipation B $T_C = 100^{\circ}C$ 20 T_△=25°C 2.5 P_{DSM} W Power Dissipation A T_△=70°C 1.6 Junction and Storage Temperature Range T_J, T_{STG} -55 to 150 °C

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	16.7	25	°C/W			
Maximum Junction-to-Ambient A	Steady-State	IN _θ JA	40	50	°C/W			
Maximum Junction-to-Case ^C	Steady-State	$R_{ hetaJL}$	1.9	2.5	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC I	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$	20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V			1	μΑ
		T _J =55°	C		5	
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±4.5V			±1	μΑ
		V_{DS} =0V, V_{GS} =±8V			±10	μΑ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	0.4	0.6	1	V
I _{D(ON)}	On state drain current	V _{GS} =4.5V, V _{DS} =5V				Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =10A		18	22	mO
		T _J =125°	C	25	31	mΩ
		V _{GS} =2.5V, I _D =8A		21	26	mΩ
		V _{GS} =1.8V, I _D =5A		26	34	mΩ
9 FS	Forward Transconductance	V _{DS} =5V, I _D =10A		30		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.76	1	V
I _S	Maximum Body-Diode Continuous Current ^G					Α
DYNAMI	CPARAMETERS					
C _{iss}	Input Capacitance			1160		pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz		187		pF
C _{rss}	Reverse Transfer Capacitance			146		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.5		Ω
SWITCH	NG PARAMETERS		•			•
Q_g	Total Gate Charge			16		nC
Q_{gs}	Gate Source Charge	V_{GS} =4.5V, V_{DS} =10V, I_{D} =10A		8.0		nC
Q_{gd}	Gate Drain Charge			3.8		nC
t _{D(on)}	Turn-On DelayTime			6.2		ns
t _r	Turn-On Rise Time	V_{GS} =5V, V_{DS} =10V, R_L =1 Ω ,		12.7		ns
t _{D(off)}	Turn-Off DelayTime	R_{GEN} =3 Ω		51.7		ns
t _f	Turn-Off Fall Time			16		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A, dI/dt=100A/μs		17.6		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =10A, dI/dt=100A/μs		6.5		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature of 150°C may be used if the PCB allows it to.

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B. The power dissipation P_0 is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T_{I(MAX)}=150°C.

D. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to case R $_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is limited by bond-wires.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

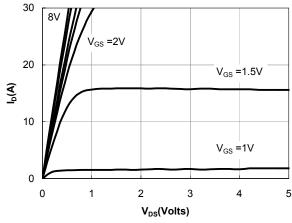


Figure 1: On-Regions CharacteristiCS

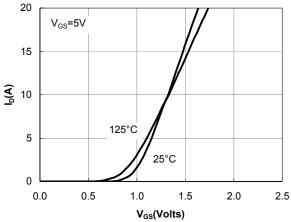


Figure 2: Transfer Characteristics

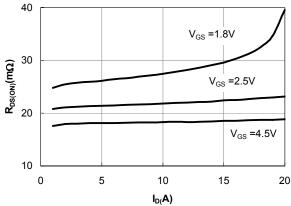


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

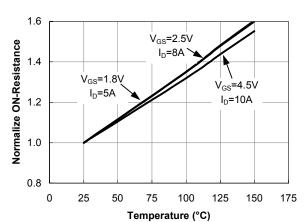


Figure 4: On-Resistance vs. Junction Temperature

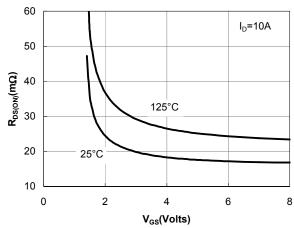


Figure 5: On-Resistance vs. Gate-Source Voltage

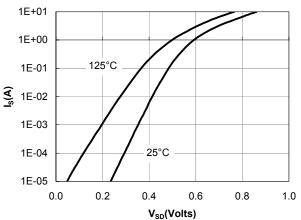


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

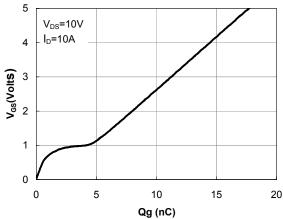


Figure 7: Gate-Charge Characteristics

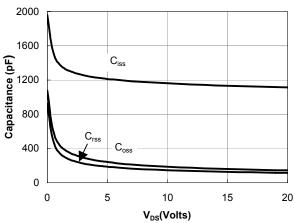


Figure 8: Capacitance Characteristics

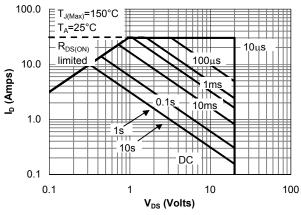


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

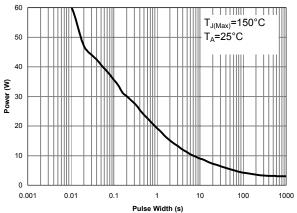


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

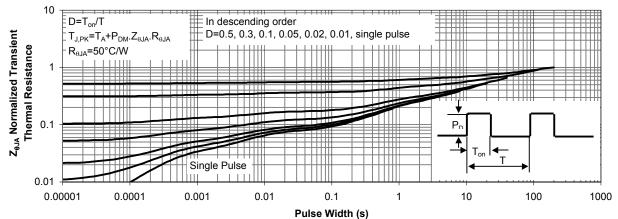


Figure 11: Normalized Maximum Transient Thermal Impedance